


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539366	<b>Applicant(s)/Patent Under Reexamination</b>  TIEKE ET AL.
	<b>Examiner</b>  ANEETA YODICHKAS	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner
369	59.11, 59.12	4/2/2008	AVP

SEARCH NOTES		
Search Notes	Date	Examiner
East	4/2/2008	AVP
Inventor Search	4/3/2008	AVP
Consulted with Joseph Haley	4/2/2008	AVP
Consulted with Wayne Young	4/2/2008	AVP
EAST	10/23/08	A.P.
EAST with Text Search	4/6/09	A.Y.
EAST with Text Search	10/16/09	A.Y.
EAST Search	2/25/10	A.Y.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See attached EAST search	2/25/10	A.Y.

/A. Y./ Examiner.Art Unit 2627	
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